

Notice of References Cited	Application/Control No. 10/620,658	Applicant(s)/Patent Under Reexamination SCHMUCK ET AL.	
	Examiner EDWYN LABAZE	Art Unit 2876	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,855,583	08-1989	Fraser et al.	235/492
	B	US-5,410,642	04-1995	Hakamatsuka et al.	358/1.14
	C	US-5,888,624	03-1999	Haghiri et al.	428/195.1
	D	US-6,002,383	12-1999	Shimada, Naoki	345/87
	E	US-6,390,375	05-2002	Kayanakis, Georges	235/492
	F	US-6,497,371	12-2002	Kayanakis et al.	235/492
	G	US-6,786,419	09-2004	Kayanakis, Georges	235/492
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
✓	N	JP 2002373323 A	12-2002	Japan	HISAYOSHI, SAYURI	G06K 19/077
✓	O	JP 2003085510 A	03-2003	Japan	MAEKAWA et al.	G06K 19/07
✓	P	JP 2003187211 A	07-2003	Japan	MAEKAWA et al.	G06K 19/077
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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